

Enhancement Mode N-Channel Power MOSFET

 $TO-252/NMOS/40V/\pm 20V/1.8V/120A/3m\Omega$

Rev0.5





40V, 3mΩ, 120A, N-Channel Enhancement MOSFET

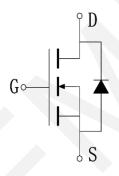
1.Features

- ◆ 40V MOSFET technology
- ◆ Low on-state resistance
- Fast switching
- ♦ Vgs±20V

- ◆ Power Switching Application
- Load Switching



V _{DS}	R _{DS(on)} Typ.	I _D Max.	
40) (3mΩ @ 10V	4004	
40V	4mΩ @ 4.5V	120A	



Schematic Diagram

3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WP40H20K	WP40H20K	TO-252	2,500	25,000

4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	$V_{ extsf{DSS}}$	40	V
Gate to Source Voltage	V _{GSS}	±20	V
Drain Current (DC)	ID	120	А
Drain Current (Pulse), PW≤300μs	I DP	330	А
Total Dissipation	P_{D}	120	W
Avalanche Energy, Single Pulsed	Eas	576	mJ
Junction Temperature	Tj	T _j 175	
Storage Temperature	T_{stg}	-55 to +175	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



5. Thermal Resistance Ratings

Parameter	Symbol	Value	Unit
Junction to Case	Rejc	1.25	°C/W

Note 2: When mounted on 1 inch square copper board $t \le 10$ sec The value in any given application depends on the user's specific board design.

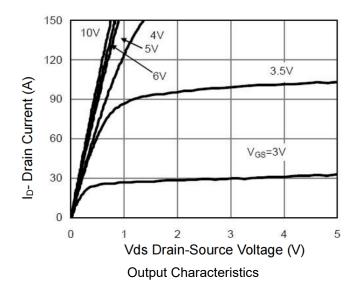
6.Electrical Characteristics at Ta=25°C (Note 3)

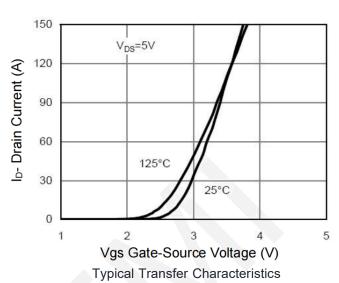
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$I_D = 250 \mu A$, $V_{GS} = 0 V$	40	46		V
Zero-Gate Voltage Drain Current	I _{DSS}	V _{DS} =40V, V _{GS} = 0V			1	μΑ
Gate to Source Leakage Current	Igss	$V_{GS} = \pm 20V$, $V_{DS} = 0V$			±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V _{DS} =V _{GS} , I _{DS} =250µA	1.0	1.8	2.5	V
Static Drain to Source On-State	Б	I _D =20A, V _{GS} = 10V	1	3	4	mΩ
Resistance	R _{DS(on)}	I _D = 10A, V _{GS} = 4.5V	-	4	7	mΩ
Input Capacitance	C _{iss}	V _{GS} =0V,		5400		pF
Output Capacitance	Coss	V _{DS} =20V,		970		pF
Reverse Transfer Capacitance	Crss	Frequency=1.0MHz		380		pF
Turn-ON Delay Time	t _{d(on)}			15		ns
Rise Time	tr	$V_{DD} = 20V, R_L = 1\Omega,$		18		ns
Turn-OFF Delay Time	$t_{\sf d(off)}$	$V_{GS} = 10V, I_{D} = 30A,$ $R_{GEN} = 3\Omega$		52		ns
Fall Time	t _f			23		ns
	Qg	V _{DS} =20V,		75		nC
Total Gate Charge	Qgs	V _{GS} = 10V,		10.5		nC
	Q _{gd}	I _D =30A		17		nC
Diode Forward Voltage	V_{FSD}	I _S =30A, V _{GS} = 0			1.2	V

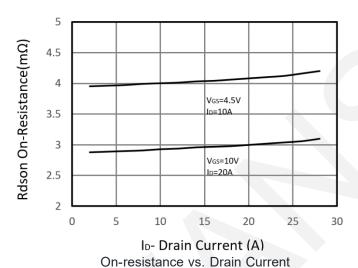
Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

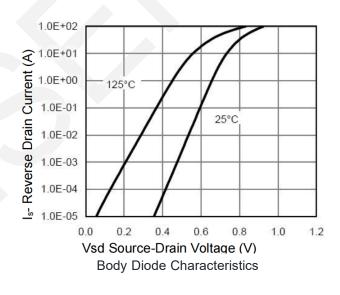


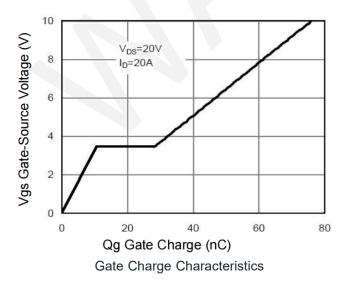
7. Typical electrical and thermal characteristics

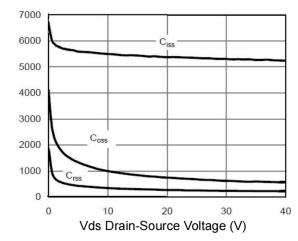










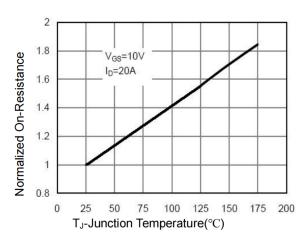


Capacitance Characteristics

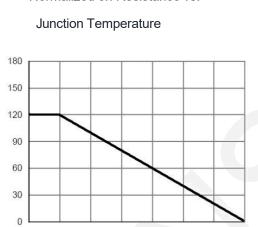
C Capacitance (pF)



Power Dissipation (W)



Normalized on Resistance vs.



Maximum Continuous Drain Current vs.

100

125

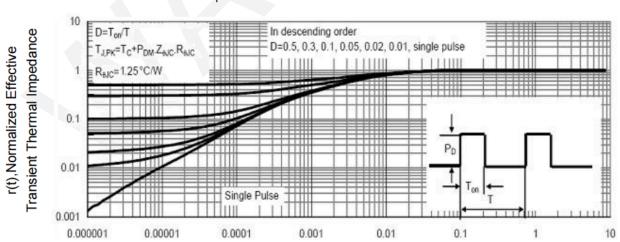
150

175

75

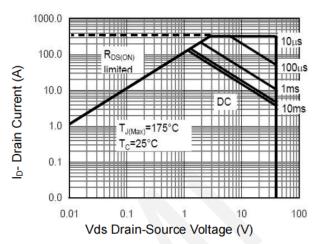
T_J-Junction Temperature (°C)

Case Temperature



Square Wave Pluse Duration(sec)

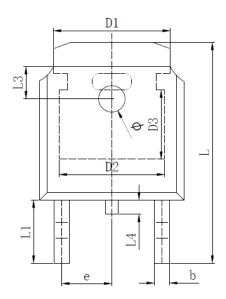
Maximum Effective Transient Thermal Impedance, Junction-to-Case

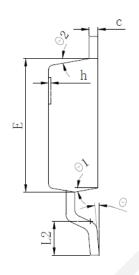


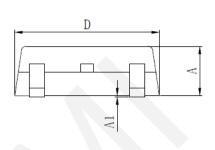
Maximum Safe Operating Area



8.Package Dimensions







SYMBOL	MILLIMETER			
	MIN	Тур.	MAX	
A	2. 200	2. 300	2. 400	
A1	0.000		0. 127	
b	0. 640	0.690	0. 740	
c(电镀后)	0. 460	0.520	0. 580	
D	6. 500	6. 600	6. 700	
D1	5.334 REF			
D2	4.826 REF			
D3	3.166 REF			
E	6. 000	6. 100	6. 200	
е	2.286 TYP			
h	0.000	0.100	0. 200	
L	9. 900	10. 100	10. 300	
L1	2.888 REF			
L2	1. 400	1.550	1. 700	
L3	1.600 REF			
L4	0.600	0.800	1. 000	
ф	1. 100	1. 200	1. 300	
θ	0°		8°	
θ1	9° TYP			
θ2	9° TYP			



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